

where we have written $\langle \tau(E) \rangle$ as explicitly dependent on the band gap $\Delta\epsilon$ (ie $\Delta E/kT$) at a particular pressure. A similar relation holds for the *s* valleys, and so equation (5) becomes

$$\rho(P) = \frac{1}{e \left\{ n_g(P) \mu_g^*(P) \frac{\langle \tau_g \Delta\epsilon \rangle}{\langle \tau_g(\infty) \rangle} + n_s(P) \mu_s^*(P) \frac{\langle \tau_s(\Delta\epsilon) \rangle}{\langle \tau_s(\infty) \rangle} \right\}} \quad (7)$$

We now examine the Hall constant for the two carrier model which can be written as

$$R_H(P) = \frac{-e^3}{3\sigma^2(P)} \left\{ n_s(P) \langle \tau_s^2(\Delta\epsilon) \rangle \frac{(K_s + 2) K_s}{m_{lg}^2} + n_g(P) \langle \tau_g^2(\Delta\epsilon) \rangle \frac{(K_g + 2) K_g}{m_{lg}^2} \right\} \quad (8)$$

This is the same formula as that given by Nathan *et al.* (1961) apart from an extra e^2 factor. If we substitute for $K_x = m_{lx}/m_{tx}$ then from equations (3)

$$\mu_x = e \langle \tau_x(E) \rangle \frac{(1 + 2K_x)}{3m_{lx}} \quad (9)$$

and a further substitution in equation (8) yields

$$R_H(P) = \frac{-e}{\sigma^2(P)} \left\{ n_s(P) \mu_s^{*2}(P) r_s^* \frac{\langle \tau_s^2(\Delta\epsilon) \rangle 3K_s(K_s + 2)}{\langle \tau_s^2(\infty) \rangle (1 + 2K_s)^2} + n_g(P) \mu_g^{*2}(P) r_g^* \frac{\langle \tau_g^2(\Delta\epsilon) \rangle 3K_g(K_g + 2)}{\langle \tau_g^2(\infty) \rangle (1 + 2K_g)^2} \right\} \quad (10)$$

where $r_x^* = \langle \tau_x^2(\infty) \rangle / \langle \tau_x(\infty) \rangle^2$.

Now let $F_x = r_x^* 3K_x(K_x + 2)/(1 + 2K_x)^2$ and take the values of K_g from the measured Ge (~ 20) and K_s from the measured Si (~ 5) results (Glickman (1956) found little variation in K_s in Ge-Si alloys before band cross-over) to give $F_g \sim 0.78 r_g^*$ and $F_s \sim 0.87 r_s^*$. It can be shown that for intervalley acoustic mode scattering $r_g^* = r_s^* = 1.18$ (and hence $F_g = 0.29$), $F_s = 1.02$ and equation (10) becomes

$$R_H = \frac{-e}{\sigma^2(P)} \left\{ 0.92 n_g(P) \mu_g^{*2}(P) \frac{\langle \tau_g^2(\Delta\epsilon) \rangle}{\langle \tau_g^2(\infty) \rangle} + 1.02 n_s(P) \mu_s^{*2}(P) \frac{\langle \tau_s^2(\Delta\epsilon) \rangle}{\langle \tau_s^2(\infty) \rangle} \right\} \quad (11)$$

To take account of the intervalley scattering Nathan *et al.* (1961) used the further scattering parameters S and S' defined by

$$S = \frac{B_g C'_s v_s}{A_g C'_g} \quad \text{and} \quad S' = \frac{B_s C'_g v_g}{A_s C'_s} \quad (12)$$

which give the relative strengths of the inter- to intra-valley scattering for the L_1 and Δ_1 states. The relaxation times to be used in equations (7) and (11) then become modified in the manner shown in the appendix.

We are left with a number of parameters which can be used to fit the data:

- (a) ΔE_0 the atmospheric pressure $\Delta_1 - L_1$ sub-band energy gap
 (b) N_0 the ratio of the density of states

$$\frac{N_{\Delta_1}}{N_{L_1}} \propto \left(\frac{m_{D\Delta_1}^*}{m_{DL_1}^*} \right)^{3/2}$$

We have used initially the experimental value of $m_{DL}^* = 0.54 m_e$, and for $m_{D\Delta}^*$ have used predicted theoretical values (see table 1).

(c) The pressure coefficient of the sub-band gap $dE(\Delta_1 - L_1)/dP$ was taken as 5.9×10^{-6} eV bar $^{-1}$. This implies that the Δ_1 minima are moving towards the valence band maximum with a pressure coefficient of -0.9×10^{-6} eV bar $^{-1}$, if the L_1 minima have the

accepted coefficient of 5.0×10^{-6} eV bar $^{-1}$. The small negative coefficient of the Δ_1 minima was estimated from the slopes of the resistivity and mobility curves beyond 55 kbar. These were less than have been observed for Si which has a pressure coefficient of -1.5×10^{-6} eV bar $^{-1}$. Our result is in agreement with the coefficient later used by Howard (1961) of -1.0×10^{-6} eV bar $^{-1}$ for unpublished magnetoconductivity measurements in n type Ge.

(d) The pressure coefficients of mobilities in the two bands. In the low pressure region, where the effect of the Δ_1 minima is small, the best fit for $\mu_g^*(P)$ was

$$\frac{\mu_g^*(0)}{(1 + 0.008P)}$$

where P is in kbar. This 0.008 variation is larger than the result of 0.004 used by Nathan *et al.* (1961), but it gave the best fit in the 0–10 kbar range. The relatively large error in our results in this pressure range, however, (figure 1) limits the accuracy of such a fit, and the discrepancy should not be considered as serious. Our variation in μ_g^* is used for the whole pressure range. The variation in the Δ_1 mobility was ignored. This is reasonable in view of the small pressure coefficient of these minima.

(e) The anisotropy K_s of the Δ_1 minima is unknown, and to a first approximation we have used the Si value, $K_s \sim 5$. We have assumed that the anisotropies of both the L_1 and Δ_1 minima will not change with pressure. Early Hall and magnetoresistance measurements to 10 kbar by Benedek *et al.* (1955) implied that a change in K_g with pressure was taking place, but this was before any effect due to the Δ_1 minima was considered. W. E. Howard and W. Paul (unpublished) have found that K_g varies to a negligible extent from magnetoconductivity measurements at pressure, and Glickman and Christian (1956) found little variation in K_s on Si–Ge alloys before band cross-over.

5. Curve fitting

The two sets of results, resistivity and Hall mobility, were fitted separately. In the diagrams

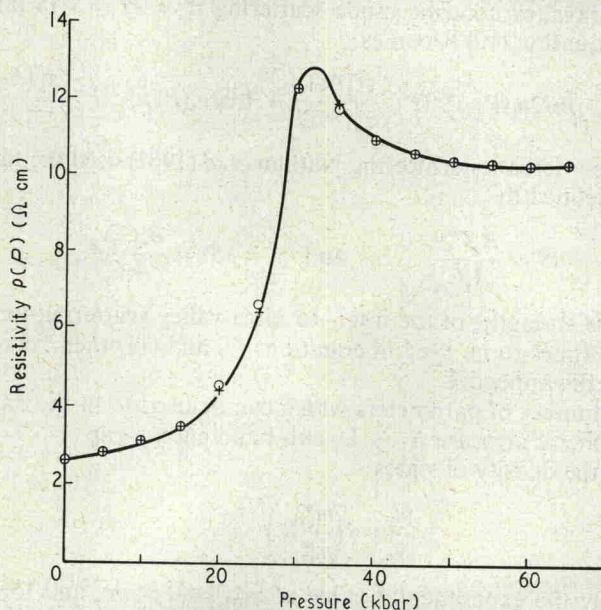


Figure 3. Theoretical fits of high pressure resistivity data in n type Ge which illustrates how higher values of N_0 lead to a greater sub-band gap ΔE_0 and scattering parameter S' , when $S (=4)$ is constant. Full curve, experimental; + $N_0 = 1.55$, $S' = 0.34$, $\Delta E_0 = 0.177$ eV; \circ $N_0 = 4.2$, $S' = 0.123$, $\Delta E_0 = 0.185$ eV.